Application/Control No. Applicant(s)/Patent Under Reexamination 10/517,955 CETNAR ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Carlos Lugo 3676 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-5,348,355 09-1994 Oyha, Takeji 292/11 Α В US-US-C US-D US-Ε US-F US-G US-Н

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